Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination		
10/668,374	KIM, BYOUNG-HAN		
Examiner	Art Unit		
Prabodh M. Dharia	2629		

SEARCHED				
Class	Subclass	Date	Examiner	
345	1.1,4,5,87, 97,103,30 117,	1/22/2007	PD	
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340	721			
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